

# Application Note

# Miscellaneous Design Tips and Facts Teccor<sup>®</sup> brand Thyristors AN1009

#### Introduction

This application note presents design tips and facts on the following topics:

- Relationship of  $I_{_{\rm AV'}}$   $I_{_{\rm RMS}},$  and  $I_{_{\rm PK}}$
- dv/dt Definitions
- Examples of gate terminations
- Curves for Average Current at Various Conduction Angles
- Double-exponential Impulse Waveform
- Failure Modes of Thyristor
- Characteristics Formulas for Phase Control Circuits

# Relationship of $\mathbf{I}_{\text{AV}}, \mathbf{I}_{\text{RMS}}, \text{and } \mathbf{I}_{\text{PK}}$

Since a single rectifier or SCR passes current in one direction only, it conducts for only half of each cycle of an AC sinewave. The average current ( $I_{AV}$ ) then becomes half of the value determined for full-cycle conduction, and the RMS current ( $I_{RMS}$ ) is equal to the square root of half the mean-square value for full-cycle conduction or half the peak current ( $I_{PK}$ ). In terms of half-cycle sinewave conduction (as in a single-phase half-wave circuit), the relationships of the rectifier currents can be shown as follows:

$$\begin{split} I_{PK} &= \pi \bullet I_{AV} = 3.14 \bullet I_{AV} \\ I_{AV} &= (1/\pi) I_{PK} = 0.32 \bullet I_{PK} \\ I_{PK} &= 2 \bullet I_{RMS} \\ I_{RMS} &= 0.5 \bullet I_{PK} \\ I_{AV} &= (2/\pi) I_{RMS} = 0.64 \bullet I_{RMS} \\ I_{RMS} &= (\pi/2) I_{AV} = 1.57 \bullet I_{AV} \end{split}$$

When two identically rated SCRs are connected inverse parallel for full-wave operation, as shown in Figure AN1009.1, they can handle 1.41 times the RMS current rating of either single SCR. Therefore, the RMS value of two half sinewave current pulses in one cycle is  $\sqrt{2}$  times the RMS value of one such pulse per cycle.





#### dv/dt Definitions

The rate-of-rise of voltage (dv/dt) of an exponential waveform is 63% of peak voltage (excluding any overshoots) divided by the time at 63% minus 10% peak voltage. (Figure AN1009.2)

Exponential dv/dt = 0.63 •  $[V_{PK}] = (t_2 - t_1)$ Resistor Capacitor circuit t = RC =  $(t_2 - t_1)$ Resistor Capacitor circuit 4 • RC =  $(t_3 - t_2)$ 







# dv/dt Definitions (continued)

The rate-of-rise of voltage (dv/dt) of a linear waveform is 80% of peak voltage (excluding any overshoots) divided by the time at 90% minus 10% peak voltage. (Figure AN1009.3)

Linear dv/dt = 0.8 = 
$$[V_{PK}] = (t_2 - t_1)$$

Linear dv/dt =  $[0.9 \bullet V_{_{PK}} - 0.1 \bullet V_{_{PK}}] = (t_2 - t_1)$ 





# **Examples of Gate Terminations**



# **Primary Purposes**

- Increase dv/dt capability
- Keep gate clamped to ensure V<sub>DRM</sub> capability Lower t<sub>a</sub> time

# **Related Effect**

Raises the device latching and holding current



#### **Primary Purposes**

- Increase dv/dt capability
- Remove high frequency noise

#### **Related Effects**

- Increases delay time
- Increases turn-on interval
- Lowers gate signal rise time
- Lowers di/dt capability
- Increases t<sub>a</sub> time

#### **Primary Purposes**

- Decrease DC gate sensitivity
- Decrease t<sub>a</sub> time

#### **Related Effects**

- Negative gate current increases holding current and causes gate area to drop out of conduction
- · In pulse gating gate signal tail may cause device to drop out of conduction



### **Primary Purpose**

Select Frequency

#### **Related Effect**

· Unless circuit is "damped," positive and negative gate current may inhibit conduction or bring about sporadic anode current



#### **Primary Purposes**

- Supply reverse bias in off period •
- Protect gate and gate supply for reverse transients
- Lower t<sub>a</sub> time

#### **Related Effects**

• Isolates the gate if high impedance signal source is used without sustained diode current in the negative cycle

#### **Primary Purpose**

Decrease threshold sensitivity

#### **Related Effects**

- · Affects gate signal rise time and di/dt rating
- Isolates the gate

#### **Primary Purpose**

Isolate gate circuit DC component

#### **Related Effects**

• In narrow gate pulses and low impedance sources, I<sub>at</sub> followed by reverse gate signals which may inhibit conduction





Zener

optional

### **Curves for Average Current at Various Conduction Angles**

SCR maximum average current curves for various conduction angles can be established using the factors for maximum average current at conduction angle of:

30° = 0.40 x Avg 180° 60° = 0.56 x Avg 180° 90° = 0.70 x Avg 180°

 $120^{\circ} = 0.84 \text{ x Avg } 180^{\circ}$ 

The reason for different ratings is that the average current for conduction angles less than 180° is derated because of the higher RMS current connected with high peak currents.

Note that maximum allowable case temperature (T<sub>c</sub>) remains the same for each conduction angle curve but is established from average current rating at 180° conduction as given in the data sheet for any particular device type. The maximum T<sub>c</sub> curve is then derated down to the maximum junction (T<sub>J</sub>). The curves illustrated in Figure AN1009.4 are derated to 125 °C since the maximum T<sub>J</sub> for the non-sensitive SCR series is 125 °C.



Figure AN1009.4

Typical Curves for Average On-state Current at Various Conduction Angles versus  $T_c$  for a SXX20L SCR.

#### **Double-Exponential Impulse Waveform**

A double-exponential impulse waveform or waveshape of current or voltage is designated by a combination of two numbers  $(t_r/t_d \text{ or } t_r \times t_d \mu s)$ . The first number is an exponential rise time  $(t_r)$  or wave front and the second number is an exponential decay time  $(t_d)$  or wave tail. The rise time  $(t_r)$  is the maximum rise time permitted. The decay time  $(t_d)$  is the minimum time permitted. Both the  $t_r$  and the  $t_d$  are in the same units of time, typically microseconds, designated at the end of the waveform description as defined by ANSI/IEEE C62.1-1989.

The rise time (tr) of a current waveform is 1.25 times the time for the current to increase from 10% to 90% of peak value. See Figure AN1009.5.

$$t_r = Rise Time = 1.25 \bullet [t_c - t_a]$$

$$t_r = 1.25 \bullet [t(0.9 |_{PK}) - t(0.1 |_{PK})] = T_1 - T_0$$

The rise time  $(t_1)$  of a voltage waveform is 1.67 times the time for the voltage to increase from 30% to 90% of peak value. (Figure AN1009.5)

$$t_r = Rise Time = 1.67 \bullet [t_c - t_b]$$

$$t_r = 1.67 \bullet [t(0.9 V_{PK}) - t(0.3 V_{PK})] = T_1 - T_0$$

The decay time  $(t_d)$  of a waveform is the time from virtual zero (10% of peak for current or 30% of peak for voltage) to the time at which one-half (50%) of the peak value is reached on the wave tail. (Figure AN1009.5)

Current Waveform  $t_d = Decay Time$ 

$$= [t(0.5 | I_{PK}) - t(0.1 | I_{PK})] = T_2 - T_0$$

Voltage Waveform  $t_d = Decay Time$ 

 $= [t(0.5 V_{PK}) - t(0.3 V_{PK})] = T_2 - T_0$ 



Figure AN1009.5 Double-exponential Impulse Waveform



Thyristor failures may be broadly classified as either degrading or catastrophic. A degrading type of failure is defined as a change in some characteristic which may or may not cause a catastrophic failure, but could show up as a latent failure. Catastrophic failure is when a device exhibits a sudden change in characteristic that renders it inoperable. To minimize degrading and catastrophic failures, devices must be operated within maximum ratings at all times.

## **Degradation Failures**

A significant change of on-state, gate, or switching characteristics is quite rare. The most vulnerable characteristic is blocking voltage. This type of degradation increases with rising operating voltage and temperature levels.

### **Catastrophic Failures**

A catastrophic failure can occur whenever the Thyristor is operated beyond its published ratings. The most common failure mode is an electrical short between the main terminals, although a Triac can fail in a half-wave condition. It is possible, but not probable, that the resulting short-circuit current could melt the internal parts of the device which could result in an open circuit.

#### **Failure Causes**

Most Thyristor failures occur due to exceeding the maximum operating ratings of the device. Overvoltage or overcurrent operations are the most probable cause for failure. Overvoltage failures may be due to excessive voltage transients or may also occur if inadequate cooling allows the operating temperature to rise above the maximum allowable junction temperature. Overcurrent failures are generally caused by improper fusing or circuit protection, surge current from load initiation, load abuse, or load failure. Another common cause of device failure is incorrect handling procedures used in the manufacturing process. Mechanical damage in the form of excessive mounting torque and/or force applied to the terminals or leads can transmit stresses to the internal Thyristor chip and cause cracks in the chip which may not show up until the device is thermally cycled.

#### **Prevention of Failures**

Careful selection of the correct device for the application's operating parameters and environment will go a long way toward extending the operating life of the Thyristor. Good design practice should also limit the maximum current through the main terminals to 75% of the device rating. Correct mounting and forming of the leads also help ensure against infant mortality and latent failures. The two best ways to ensure long life of a Thyristor is by proper heat sink methods and correct voltage rating selection for worst case conditions. Overheating, overvoltage, and surge currents are the main killers of semiconductors.

### **Most Common Thyristor Failure Mode**

When a Thyristor is electrically or physically abused and fails either by degradation or a catastrophic means, it will short (full-wave or half-wave) as its normal failure mode. Rarely does it fail open circuit. The circuit designer should add line breaks, fuses, over-temperature interrupters or whatever is necessary to protect the end user and property if a shorted or partially shorted Thyristor offers a safety hazard.



# **Characteristics Formulas for Phase Control Circuits**

Circuit Name	Max Thyristor Voltage	PRV	Max. Load Voltage	Load Voltage with Delayed Firing	Max. Average Thyristor or Rectifier Current	
		SCR	$E_d = Avg.$ $E_a = RMS Load$		Avg. Amps	<b>Conduction Period</b>
Half-wave Resistive Load	1.4 E <sub>rms</sub>	Е <sub>Р</sub>	$E_{d} = \frac{E_{p}}{\pi}$ $E_{a} = \frac{E_{p}}{2}$	$E_{d} = \frac{E_{p}}{2\pi} (1 + \cos\alpha)$ $E_{a} = \frac{E_{p}}{2\sqrt{\pi}} \sqrt{(\pi - \alpha + \frac{1}{2}\sin 2\alpha)}$	$\frac{E_{p}}{\pi R}$	180 °
Full-wave Bridge	1.4 E <sub>rms</sub>	E <sub>P</sub>	$E_{d} = \frac{2E_{p}}{\pi}$	$E_{d} = \frac{E_{p}}{2\pi} (1 + \cos \alpha)$	$\frac{E_{p}}{\pi R}$	180 °
Full-wave AC Switch Resistive Load	1.4 E <sub>rms</sub>	E <sub>P</sub>	$E_{a} = \frac{E_{p}}{1.4}$	$E_{a} = \frac{E_{p}}{2\sqrt{\pi}} \sqrt{(\pi - \alpha + \frac{1}{2} \sin 2\alpha)}$	$\frac{E_{p}}{\pi R}$	180 °

**Note:** Angle alpha ( $\alpha$ ) is in radians.



Half-wave Resistive Load – Schematic



Full-wave Bridge - Schematic



Full-wave AC Switch Resistive Load – Schematic

Half-wave Resistive Load – Waveform



Full-wave Bridge – Waveform



Full-wave AC Switch Resistive Load – Waveform

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